



Status and plan of PANDA EMC code checking, energy and position calibration

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EMC software 3, June, 2019 @Hefei



Outline

- Code checking
 - Review
 - New
- Energy calibration (by Dong Liu)
 - Status
 - plan
- Position calibration (by Yankun Sun)
 - Status
 - plan
- Summary

Code checking

Code checking: review

- EMC Software

- Simulation

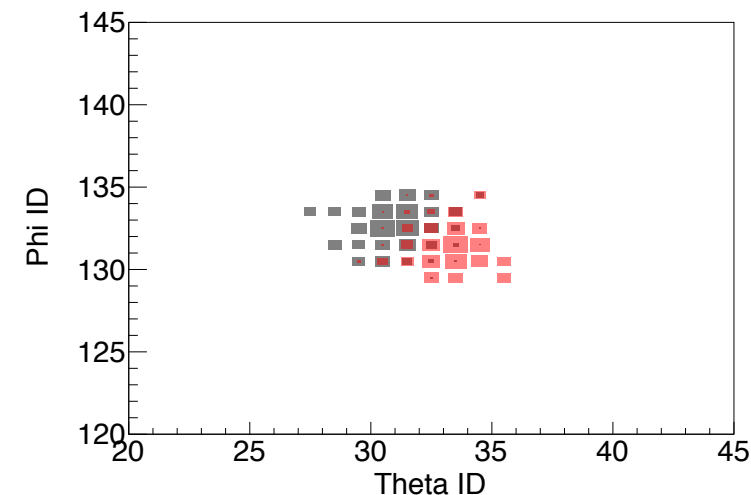
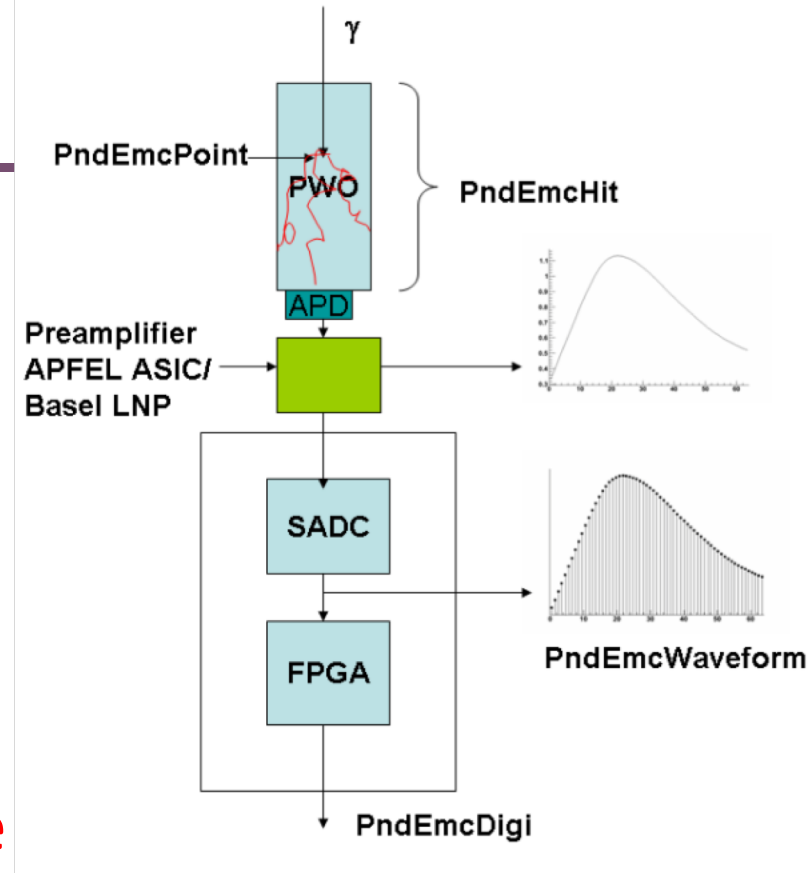
- geometry description
 - sensitive material
 - physical processes
 - signal collection
 - digitization

- Reconstruction

- cluster finding
 - bump splitting

Until 17/12/18
collaboration
meeting

Code works fine





Code checking: status and plan

➤ Status

- ☐ Data processing from injection to bump has been checked

➤ Plan

- ☐ Check codes for energy and position calibration
- ☐ Check codes for PID
- ☐ Optimize and develop codes

Energy calibration

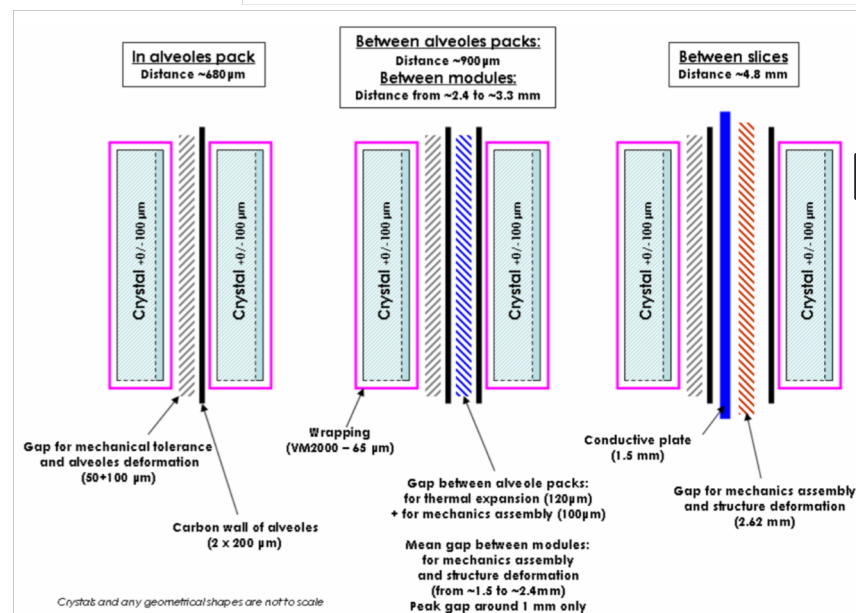
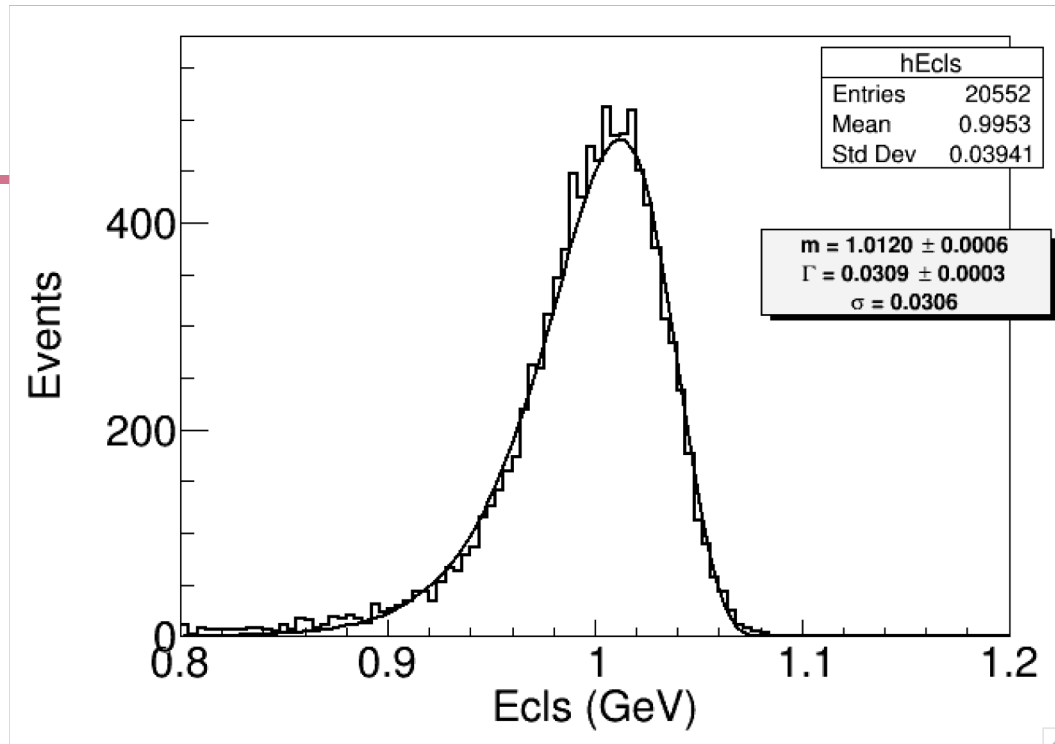
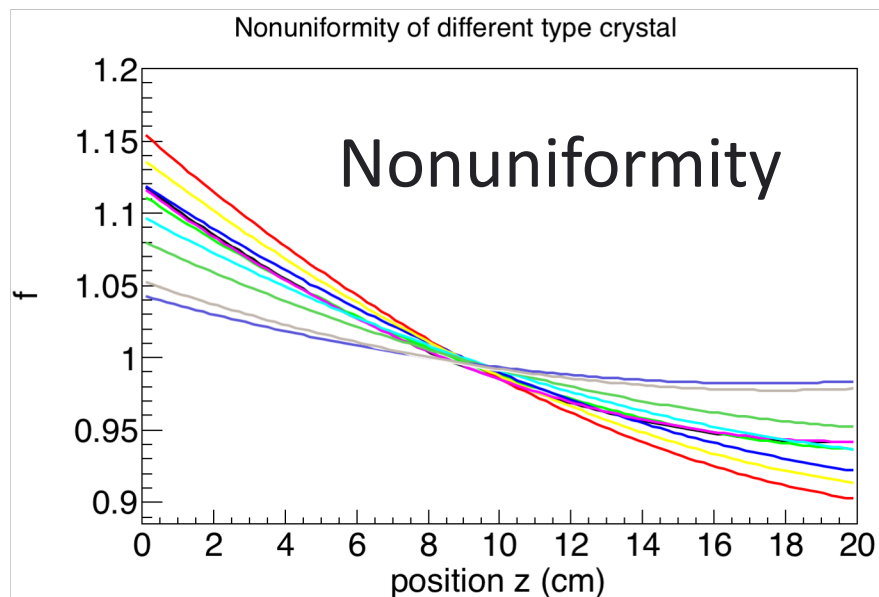
Energy calibration

- Energy calibration
 - Design in TDR

$$\frac{\sigma_E}{E} = a \oplus \frac{b}{\sqrt{E/\text{GeV}}} \quad (3.1)$$

leads to the requirement $a \leq 1\%$ and $b \leq 2\%$.

- Reasons



Dead area

Figure 7.8: Summary of the expected dead space between calorimeter elements.

Energy calibration

TDR

$E_{\gamma, \text{cor}} = E * f(\ln E, \Theta)$ with

$$f(\ln E, \Theta) = \exp(a_0 + a_1 \ln E + a_2 \ln^2 E + a_3 \ln^3 E \\ + a_4 \cos(\Theta) + a_5 \cos^2(\Theta) + a_6 \cos^3(\Theta) \\ + a_7 \cos^4(\Theta) + a_8 \cos^5(\Theta) \\ + a_9 \ln E \cos(\Theta))$$

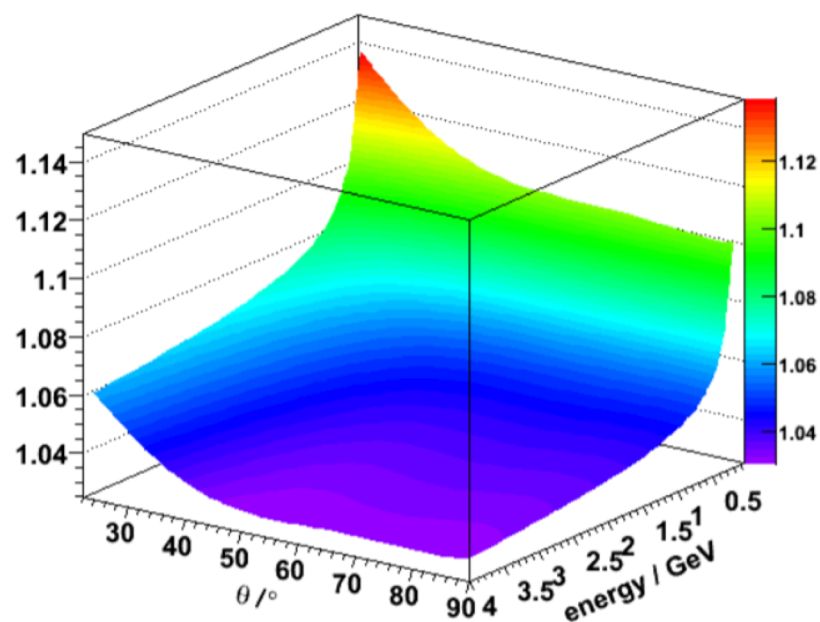
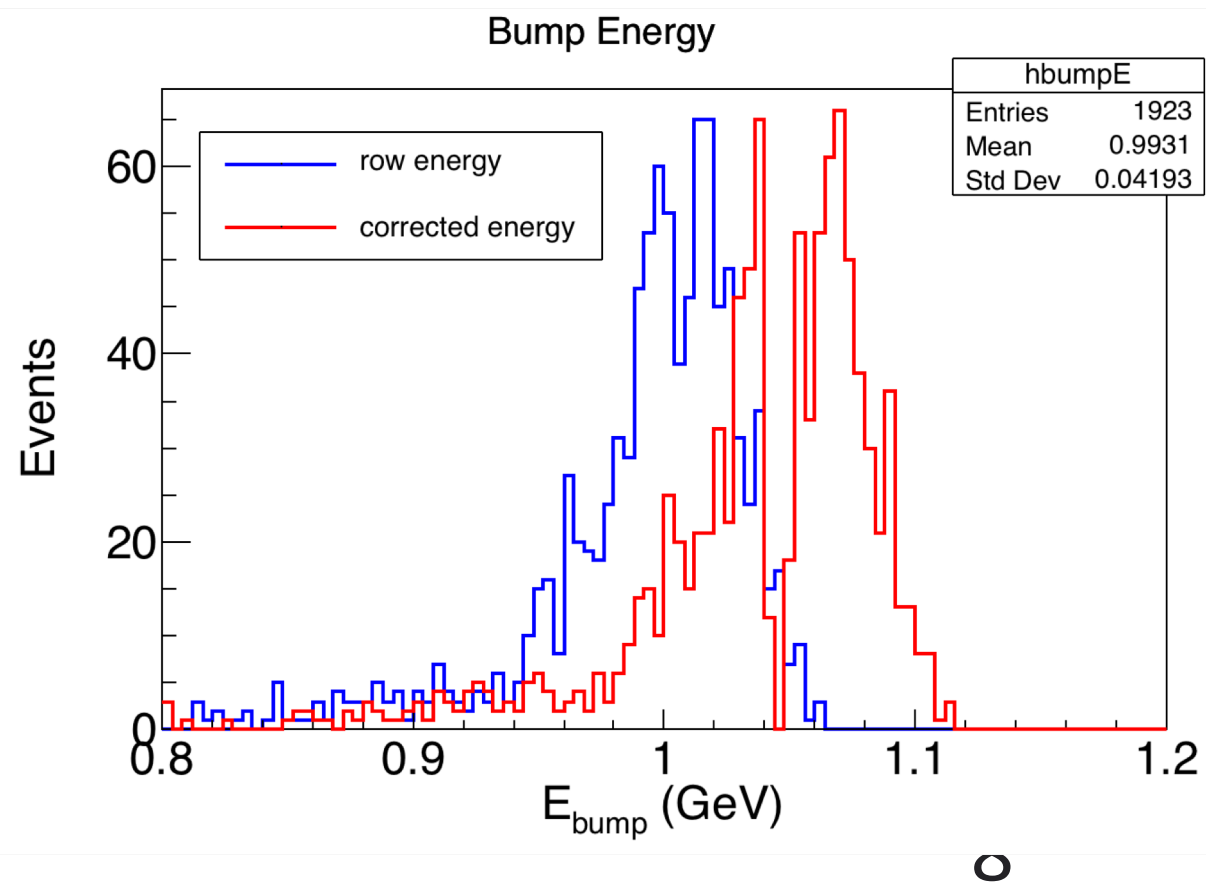


Figure 9.3: Leakage correction function for the barrel EMC in the Θ range between 22° and 90° .

In PandaRoot

```
double eout1=e* exp(factor1); // factor123 are from  
double eout2=e* exp(factor2); // TDR but diff par  
double eout3=e* exp(factor3);
```





Energy calibration

Plan

- ❑ Firstly, crystal calibration
- ❑ Then, bump correction
 - $C = f(E_{\text{crstal}}, E_{\text{bump}}, E1/E9, r, \text{moment}, \text{theta}, \dots)$
- ❑ Front material?
- ❑ monitor temperature, not by us

Energy calibration

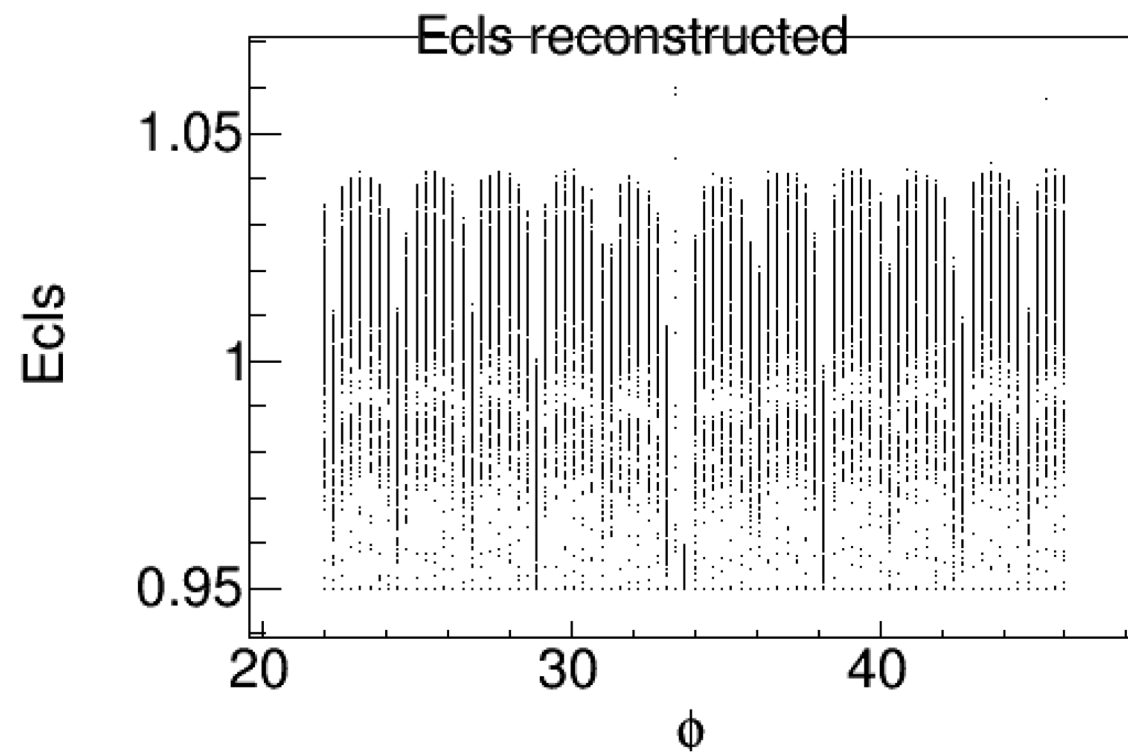
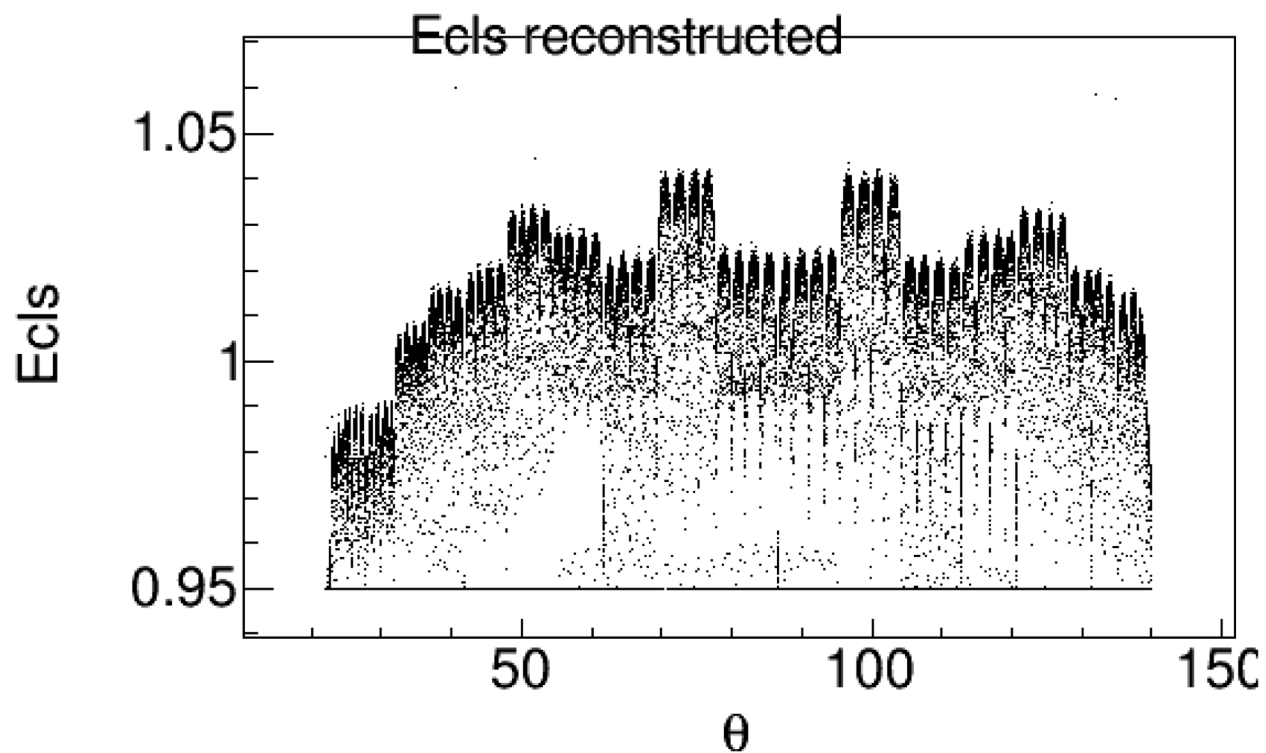
Scan theta and phi, one slice,
 $E_\gamma = 1$ GeV

theta: 22 – 140, 0.3 per sample

phi: 22-46, 0.3 per sample

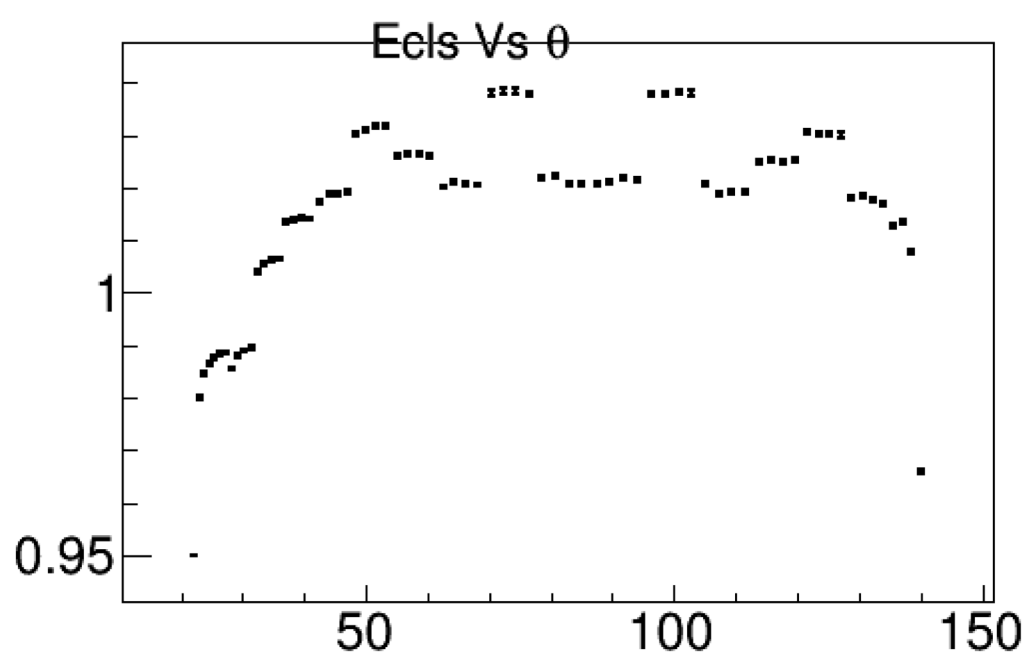
1000 events per sample

> 30 k samples

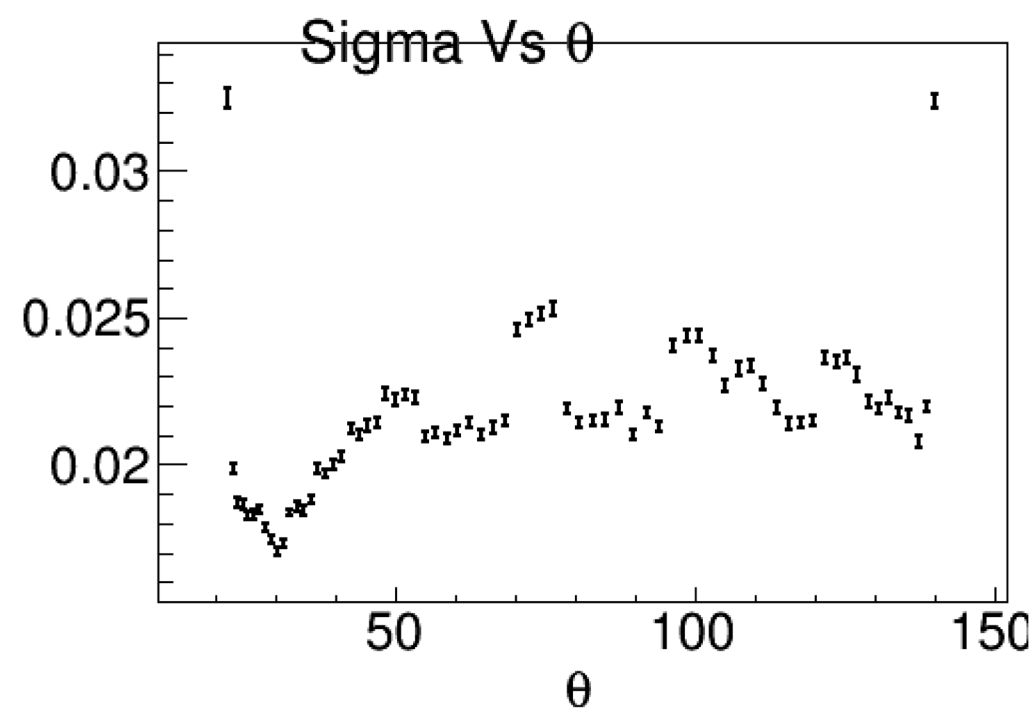




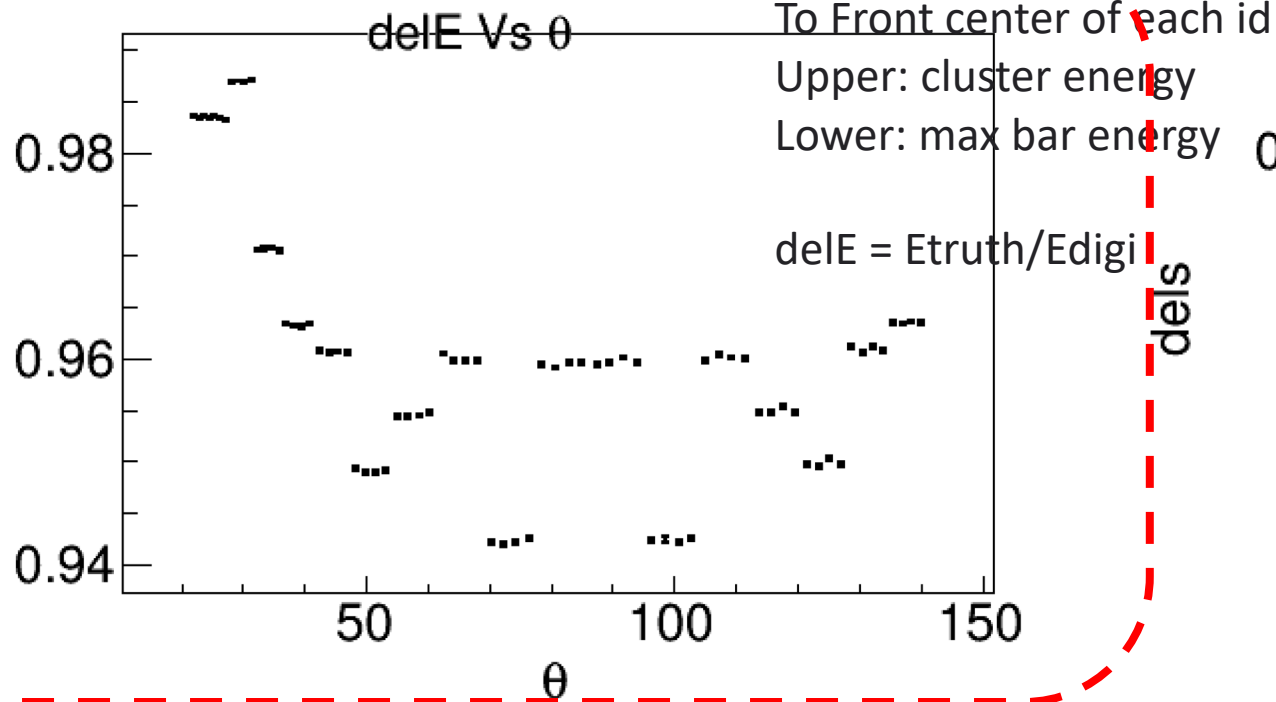
Ecls



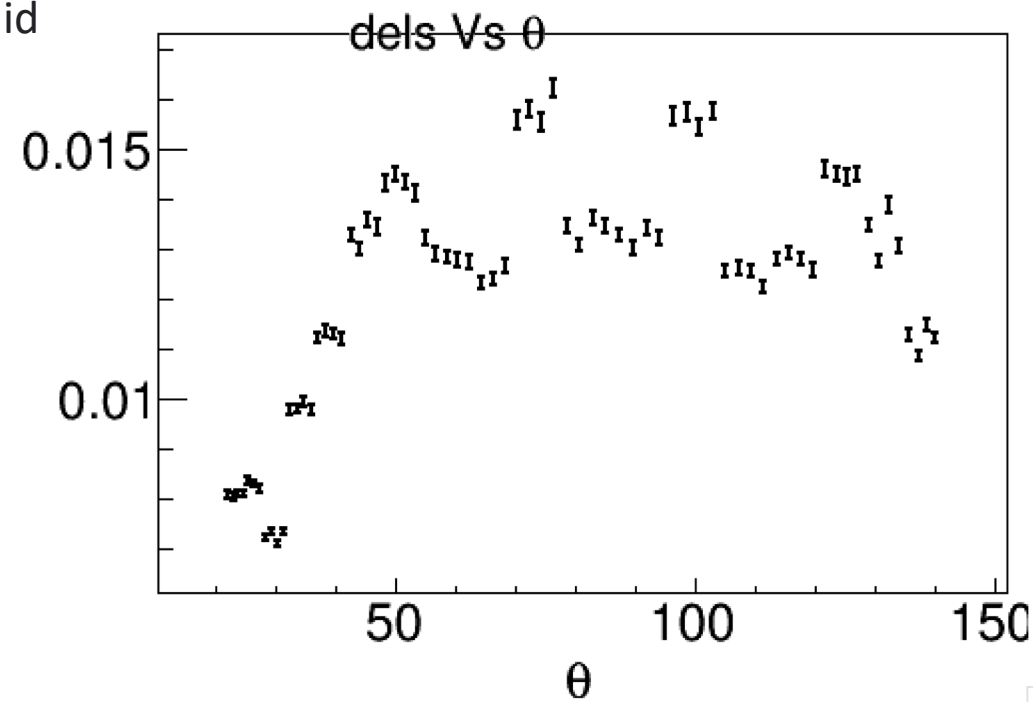
Sigma



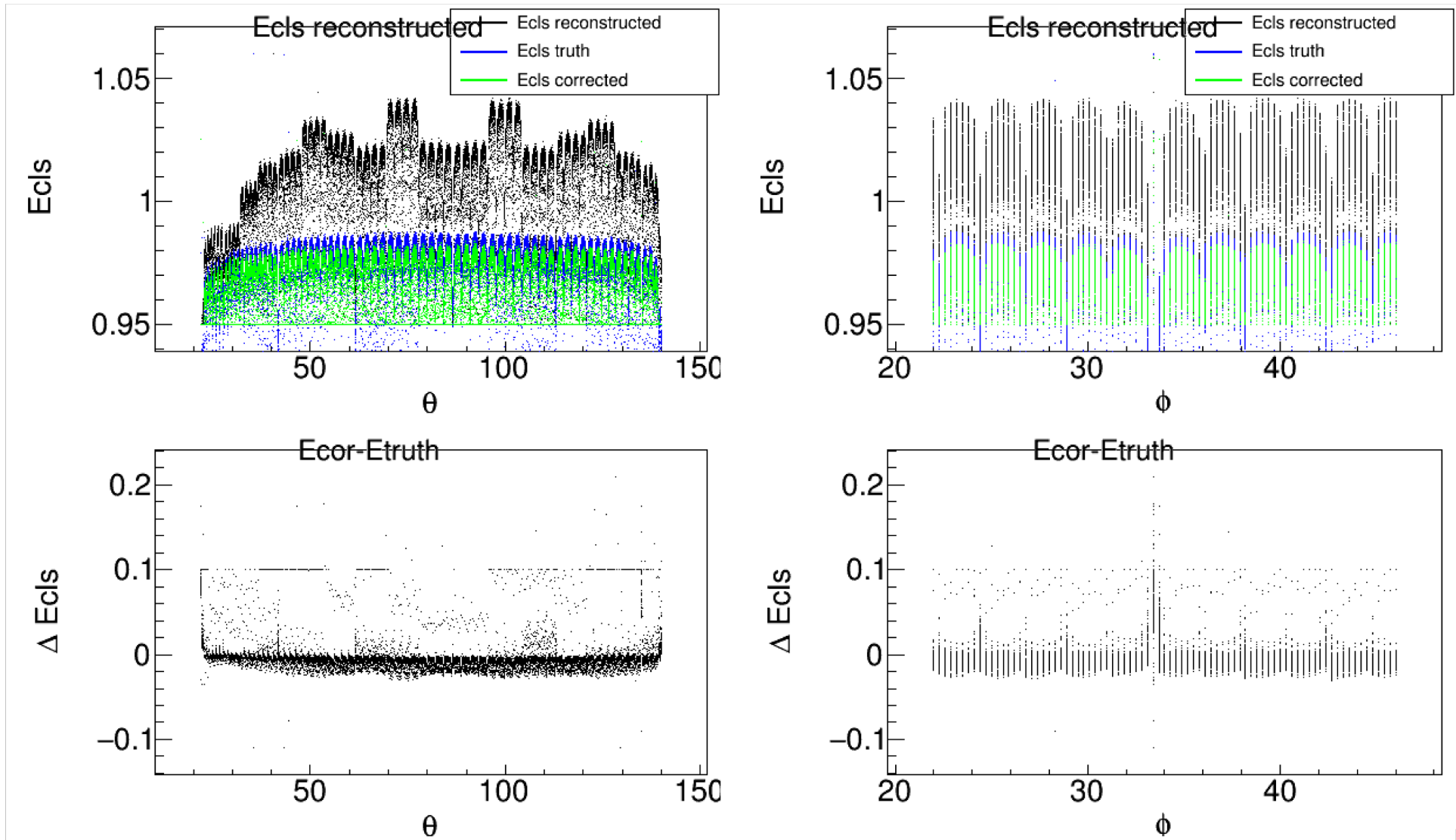
delE



dels



Energy calibration: correction based on crystal type

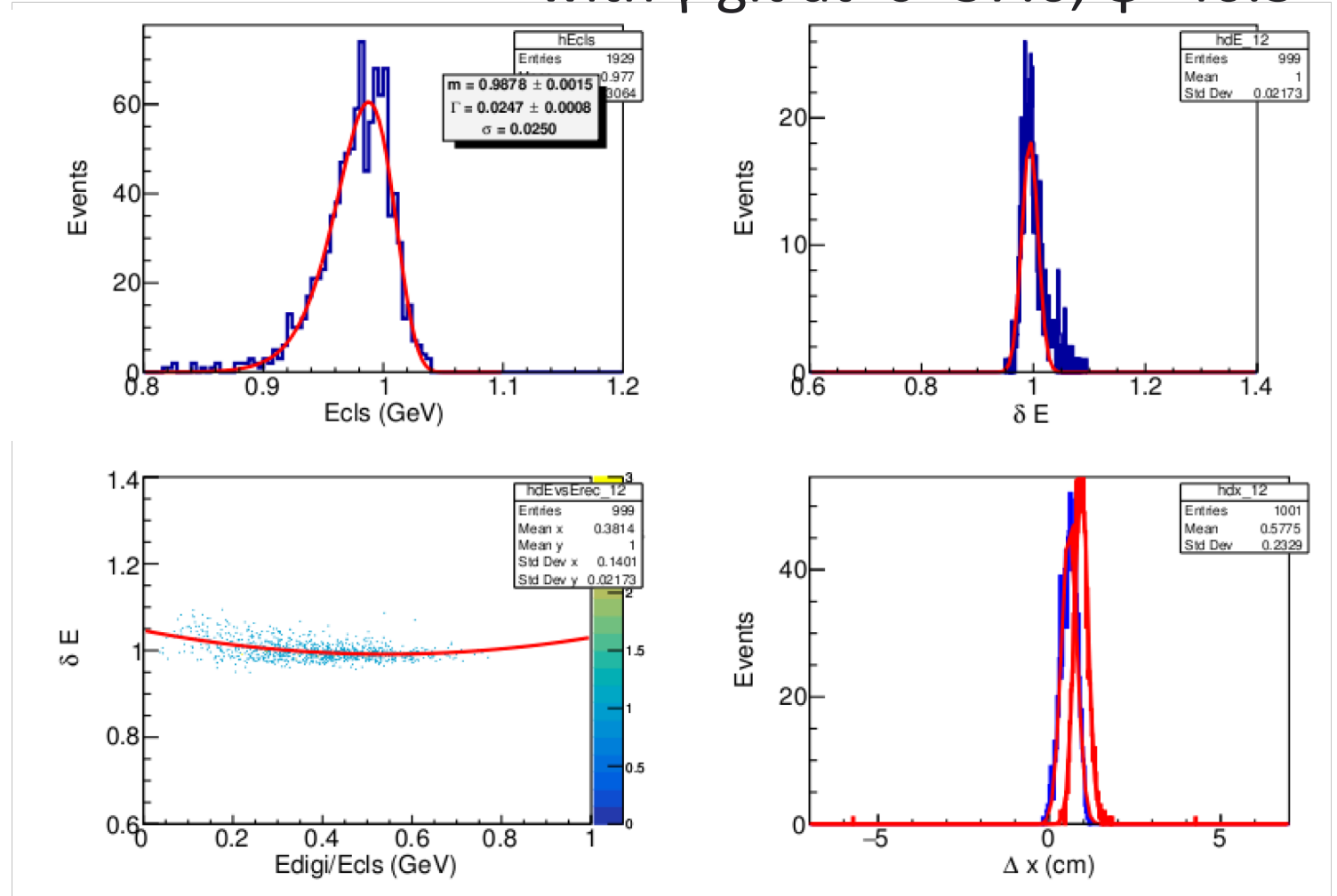


Energy calibration

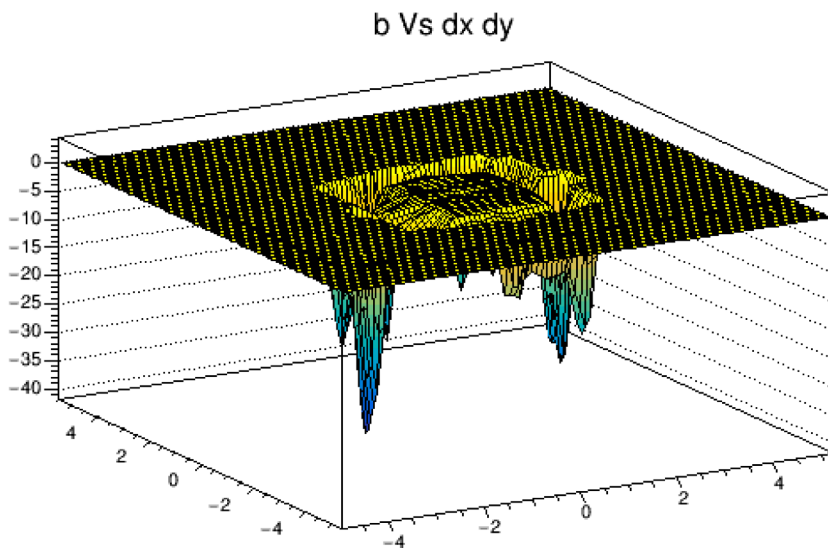
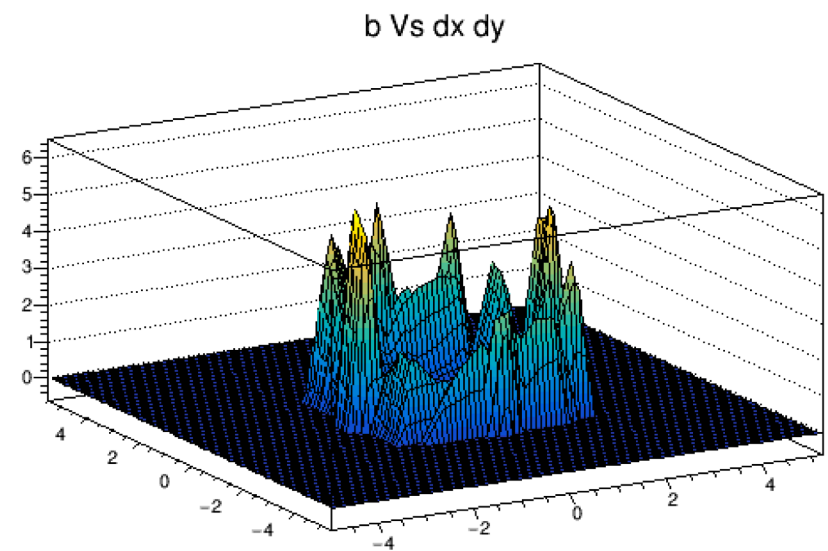
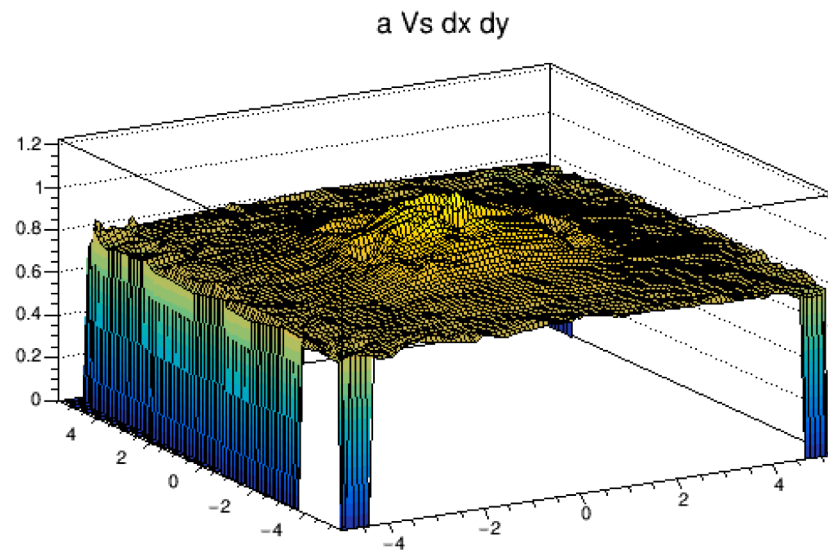
Scan theta and phi, one slice,
 $E_\gamma = 1$ GeV
theta: 22 – 140, 0.3 per sample
phi: 22-46, 0.3 per sample
1000 events per sample
> 30 k samples

For each crystal
 $f = a + bx + cx^2$
 f Vs θ, ϕ
 a, b, c Vs θ, ϕ
 $\delta E = E_{\text{truth}}/E_{\text{digi}}$

Example for crystal 12815008,
with γ git at $\theta=37.6, \phi=40.3$



Energy calibration



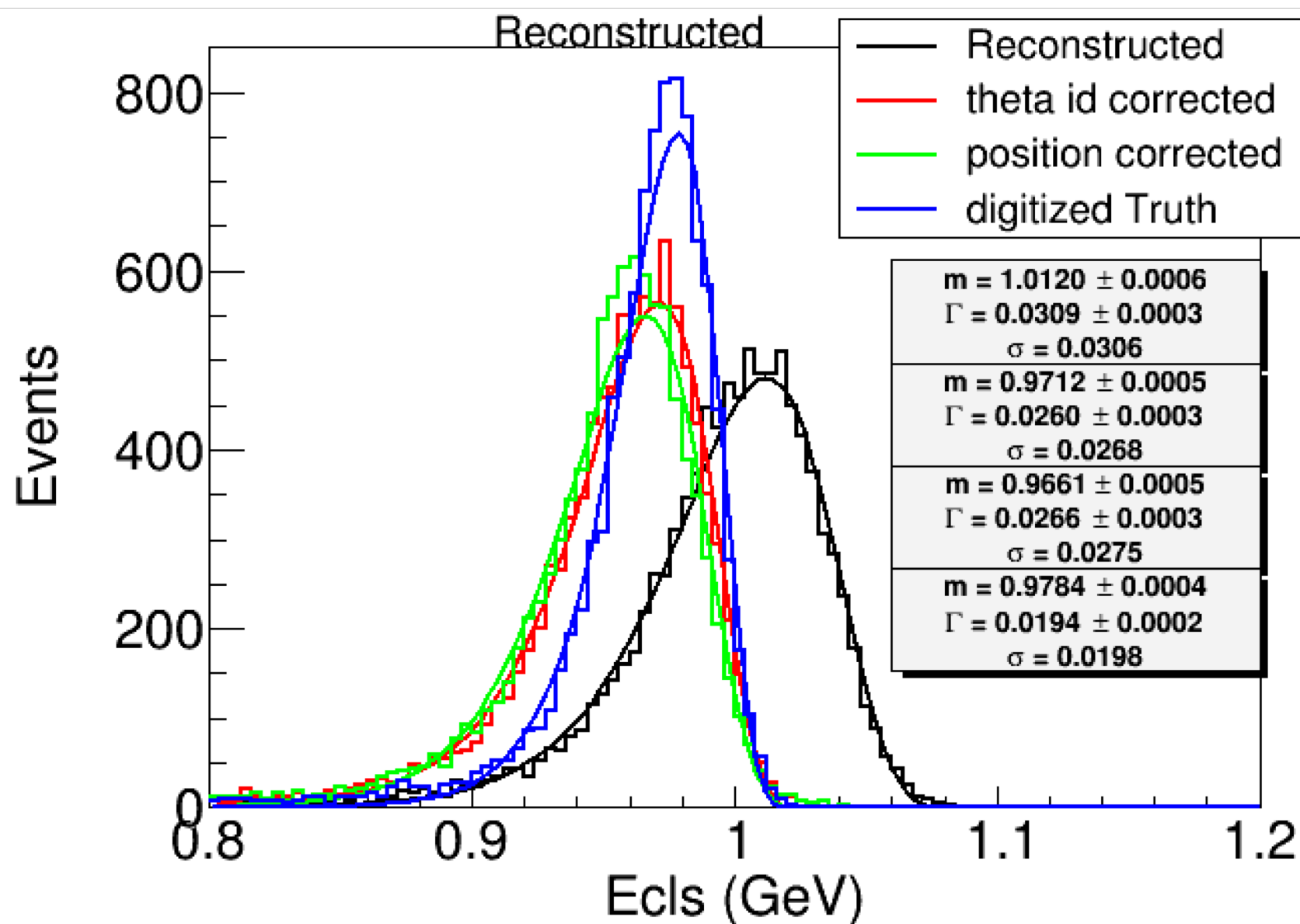
Example for crystal 12815008,
with γ git at $\theta=37.6$, $\phi=40.3$

$$f = a + bx + cx^2$$

a, b, c Vs θ, ϕ

Energy calibration

Test sample





Energy calibration: Status and Plan

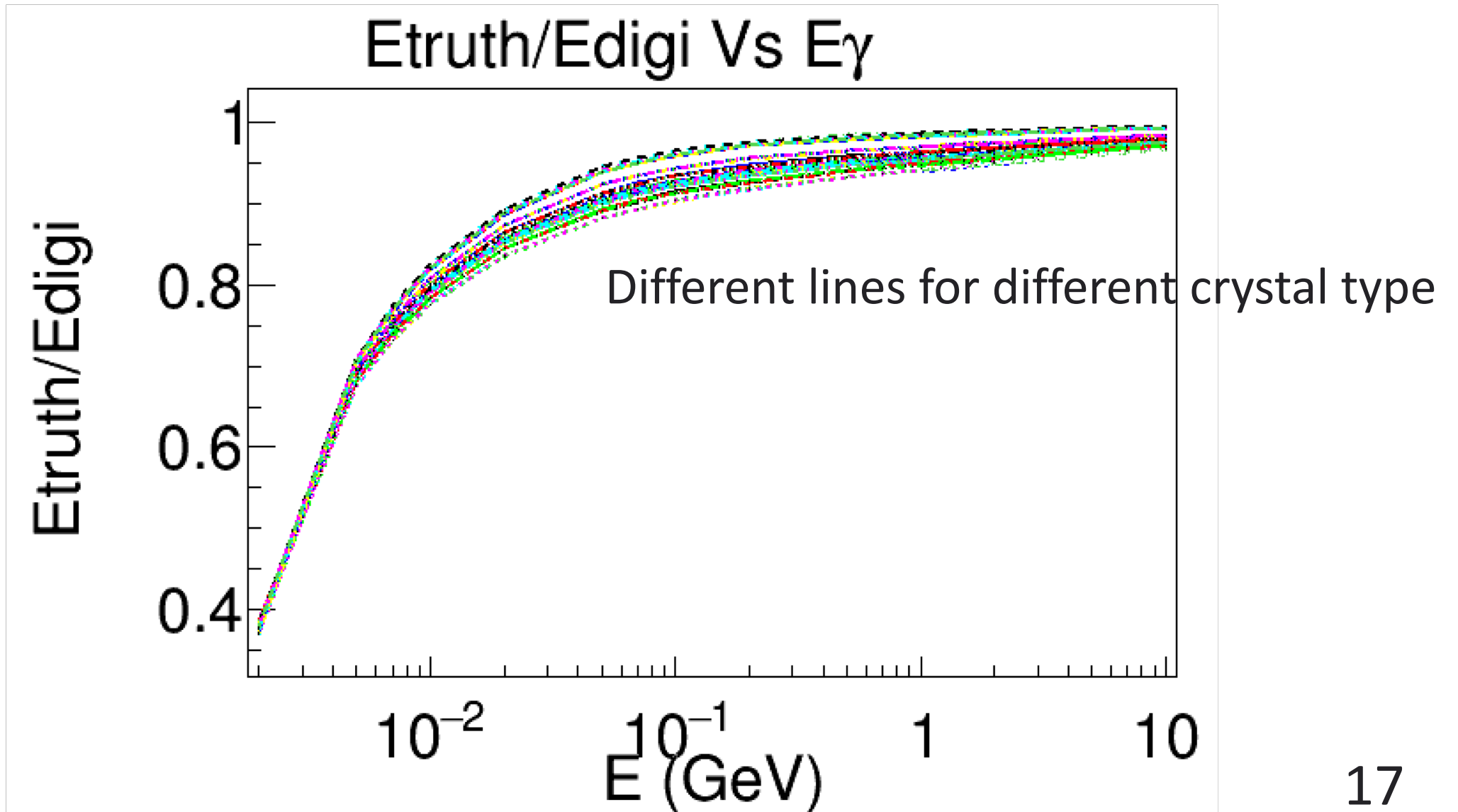
➤ Status: Calibration on each crystal

- ❑ Crystal type related correction
- ❑ Position and energy related correction

➤ Plan

- ❑ Consider energy relation for crystal type correction
- ❑ Cluster energy leakage correction, in dead area and at rear
- ❑ Nonuniformity correction
- ❑ MVA or ML for energy correction

Energy calibration: fdigi Vs Ecluster



Energy calibration: correction for leakage in dead area

Based on i theta correction

2007 JINST 2 P04004

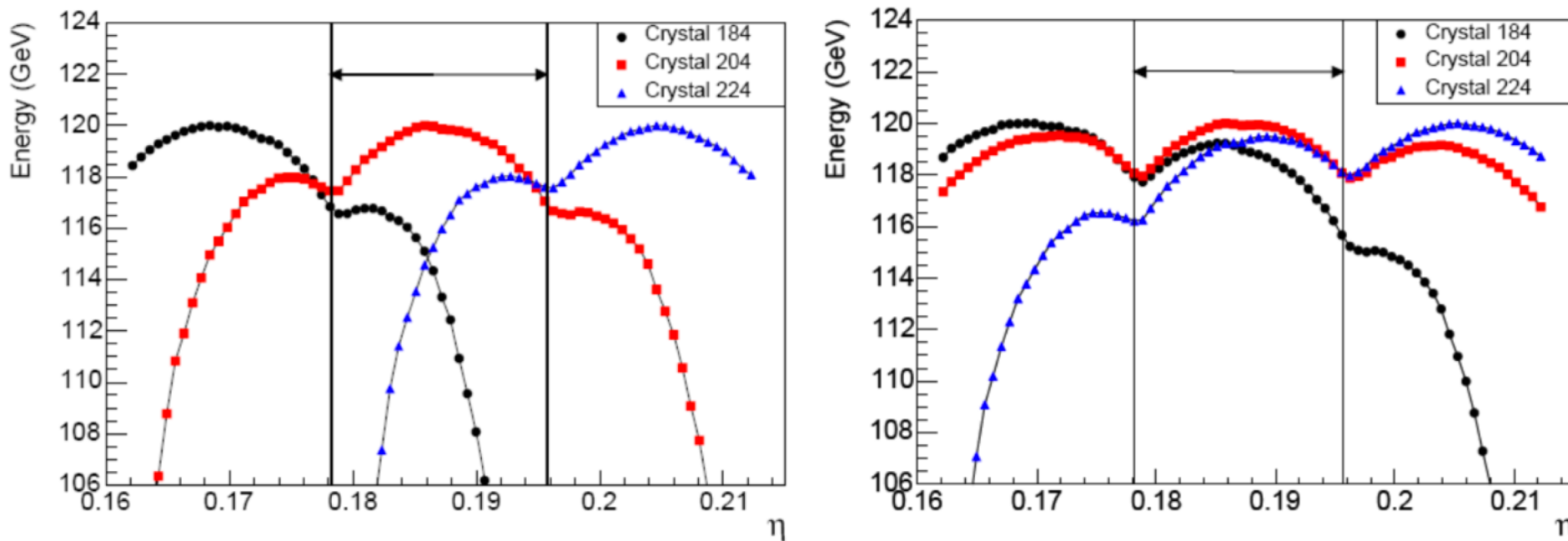


Figure 7. Left: mean energy measured in 3×3 arrays centred on crystals 184 (dots), 204 (squares), 224 (triangles) as a function of incident position, η . Right: same for 5×5 arrays. The arrows indicate the region where crystal 204 has the largest energy deposit.

Energy calibration: correction for leakage in dead area

Based on η theta correction

2007 JINST 2 P04004

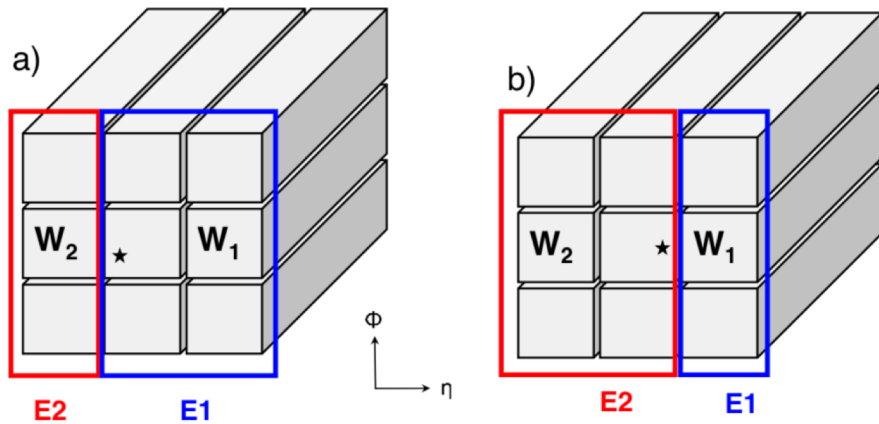


Figure 8. Definition of E1 and E2 when a) $W_1 < W_2$ and b) $W_1 > W_2$ (see text). The star represents the electron's incident position.

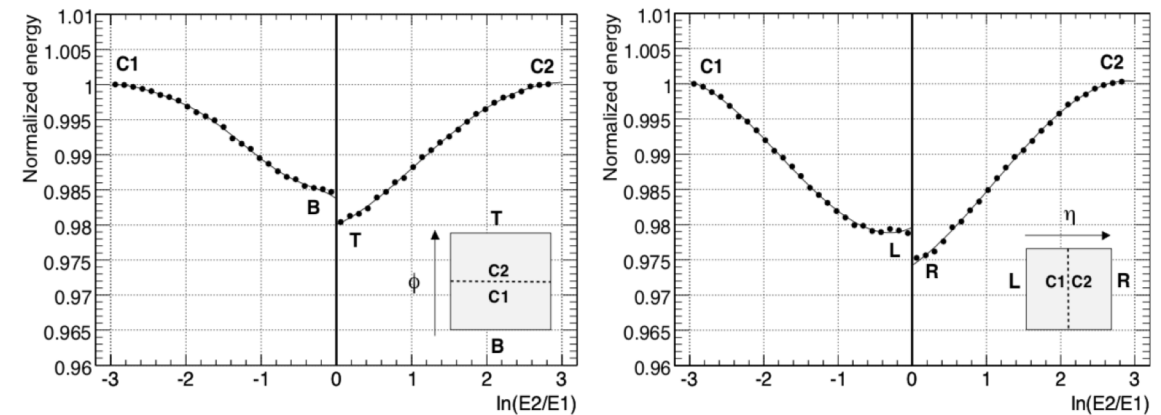


Figure 10. Normalized mean energy measured in the 3×3 array around crystal 204 versus $\ln(E_2/E_1)$ in the Φ (left) and η (right) directions. The curves are 3rd order polynomial functions fitted to the measured distributions, independently for positive and negative values of $\ln(E_2/E_1)$. The square panels represent the central crystal with various regions indicated: T (top), B (bottom), L (left), R (right) and C1 and C2 (just off centre on each side). The labels on the distributions indicate in which region the electrons were incident.

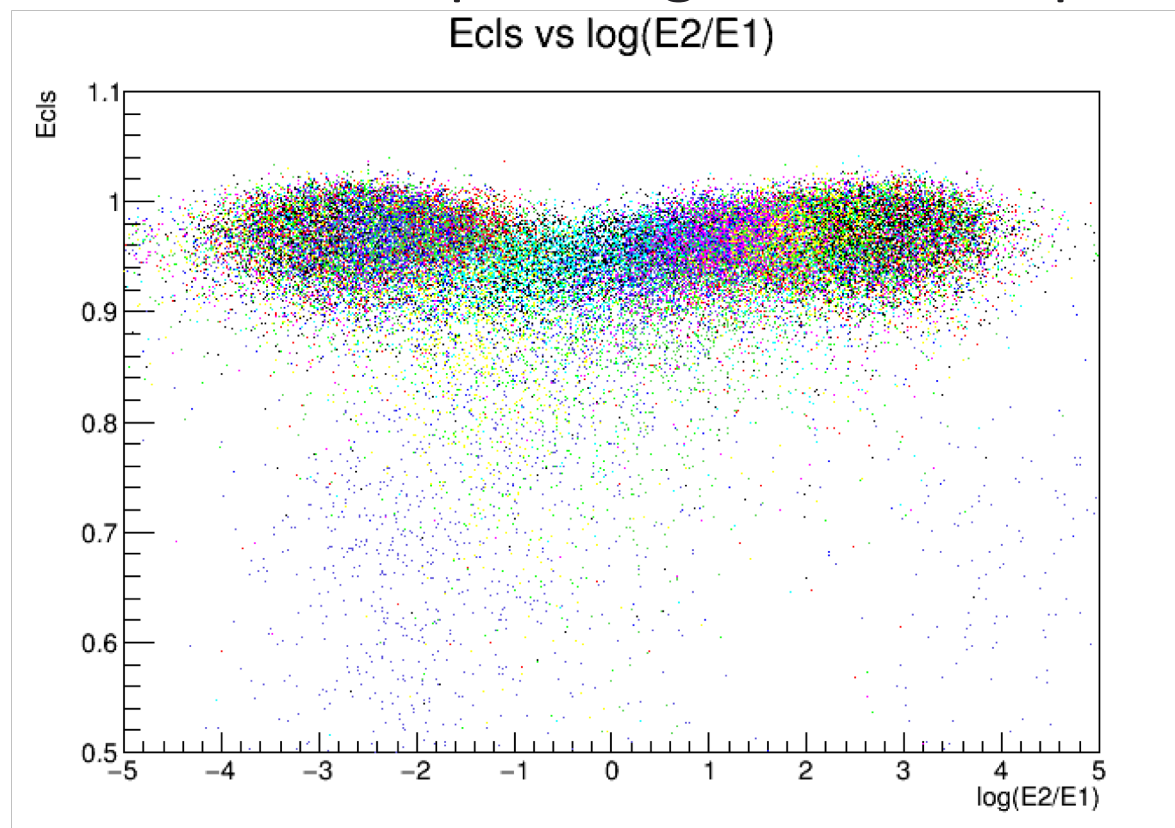
For theta and phi, the definitions of E1 and E2 are in different direction

Energy calibration: correction for leakage in dead area

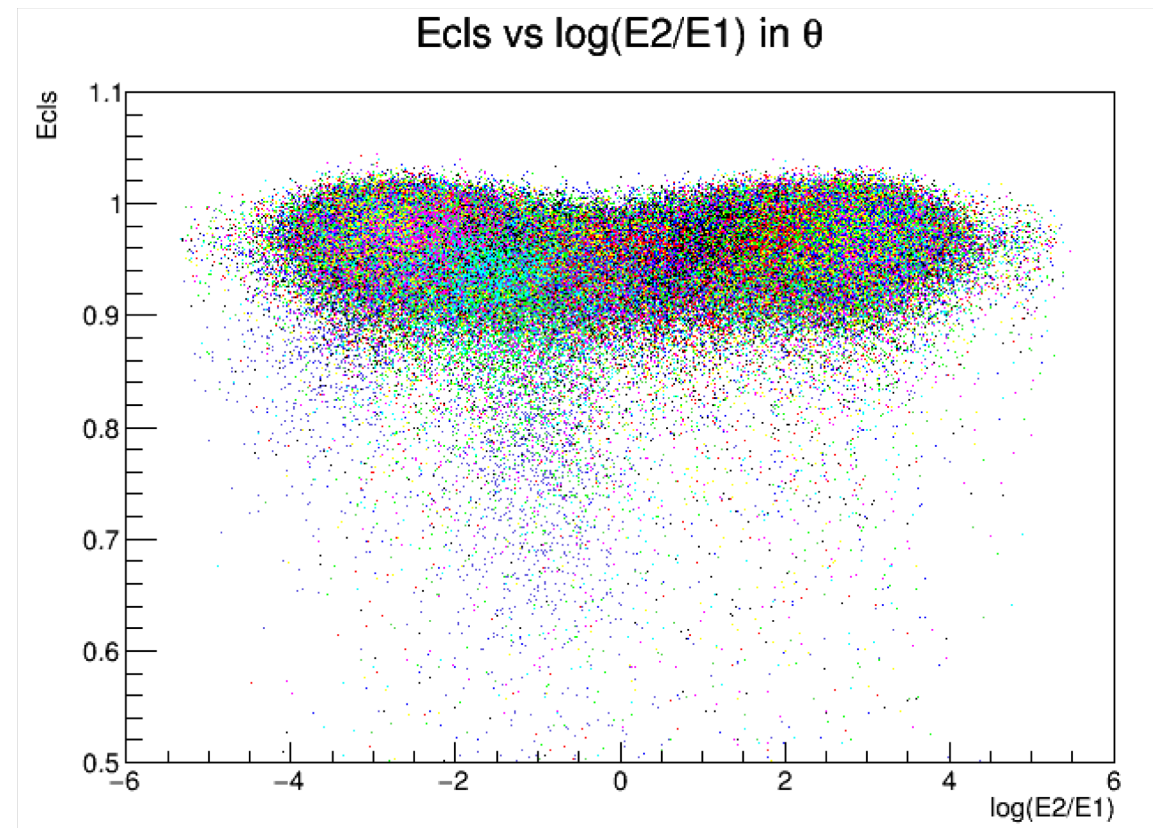
Based on i theta correction

For $\theta=49.9$

One color corresponding to one sample



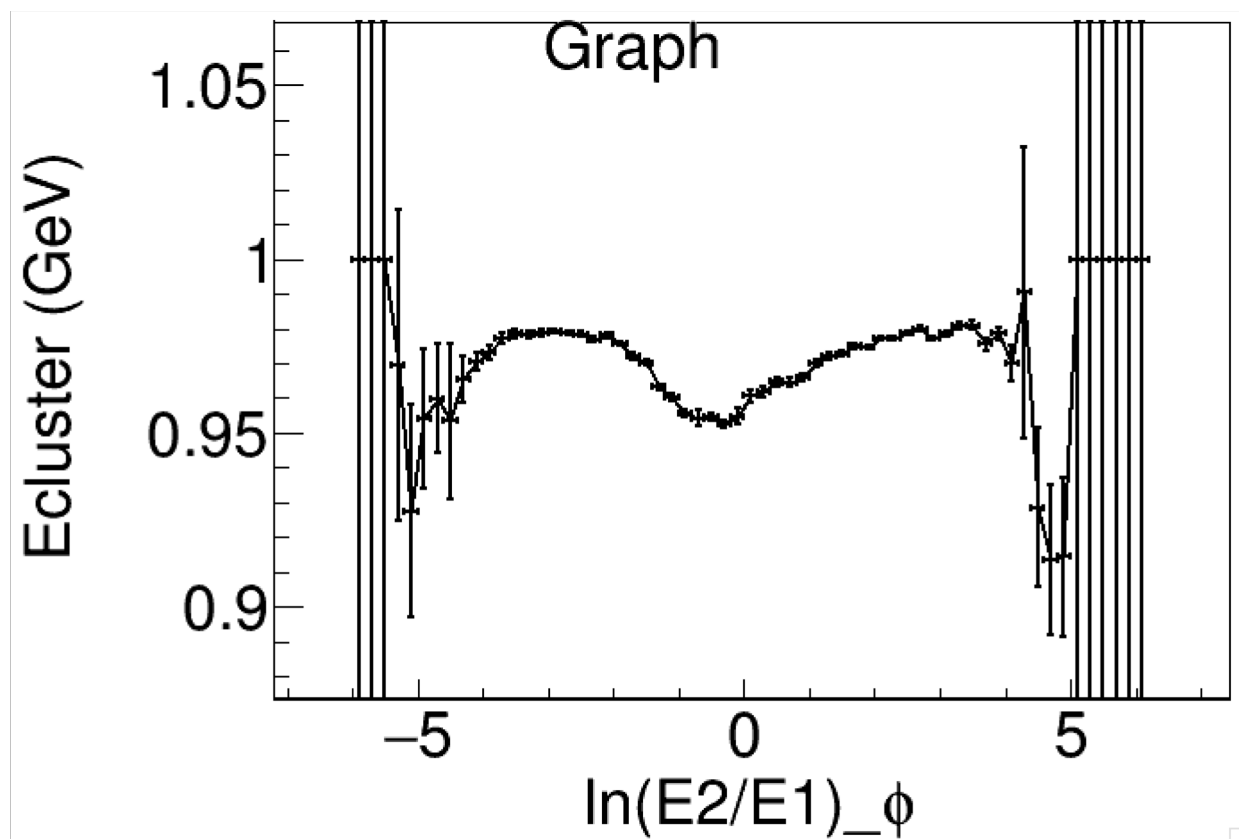
For $\phi=30.1$



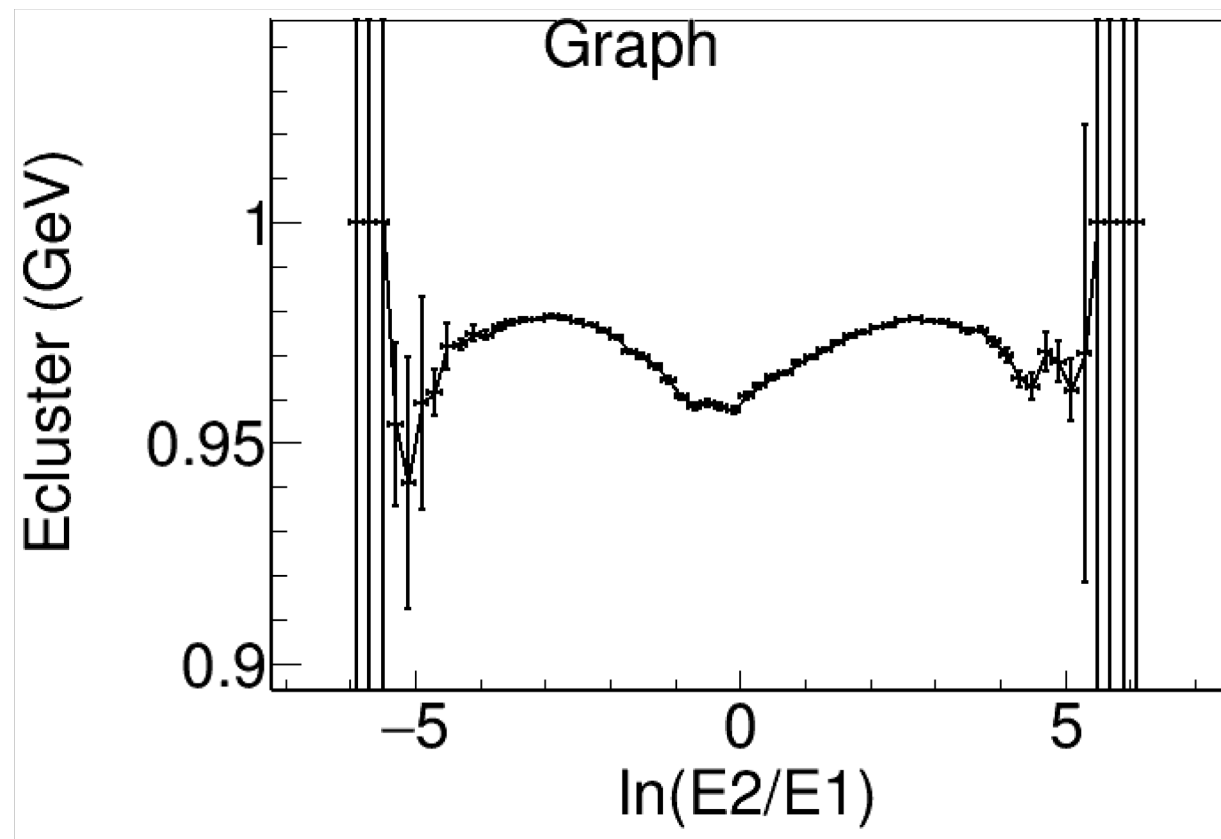
Energy calibration: correction for leakage in dead area

Based on i theta correction

For $\theta=49.9$



For $\phi=30.1$



Energy calibration: correction for leakage in dead area

For different gaps

iMod: 2								iMod: 1												alveole position
								super modules												
	SM1	SM2		SM3				SM4		SM5		SM6		SM7						
crystal shape left/right	L	7me	6me	5me	4me	3me	2me	1me	1pe	2pe	3pe	4pe	5pe	6pe	7pe	8pe	9pe	10pe	11pe	e
	R																			
	L	7md	6md	5md	4md	3md	2md	1md	1pd	2pd	3pd	4pd	5pd	6pd	7pd	8pd	9pd	10pd	11pd	d
	R																			
	L	7mc	6mc	5mc	4mc	3mc	2mc	1mc	1pc	2pc	3pc	4pc	5pc	6pc	7pc	8pc	9pc	10pc	11pc	c
	R																			
	L	7mb	6mb	5mb	4mb	3mb	2mb	1mb	1pb	2pb	3pb	4pb	5pb	6pb	7pb	8pb	9pb	10pb	11pb	b
	R																			
L	7ma	6ma	5ma	4ma	3ma	2ma	1ma	1pa	2pa	3pa	4pa	5pa	6pa	7pa	8pa	9pa	10pa	11pa	a	
R																				
	7m	6m	5m	4m	3m	2m	1m	1p	2p	3p	4p	5p	6p	7p	8p	9p	10p	11p		
								alveole type												

iCry:

10

↑

1

iCry:
10
↑
1

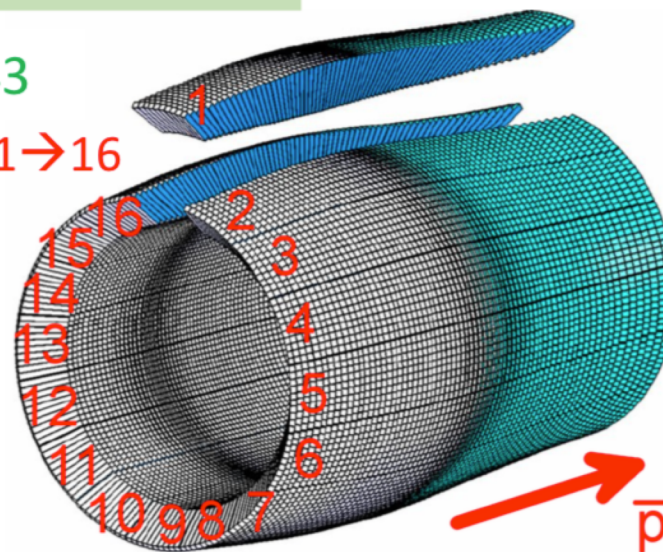
iRow: 28←1

iRow: 1→43

iCopy: 1→16

From Guang ZHAO

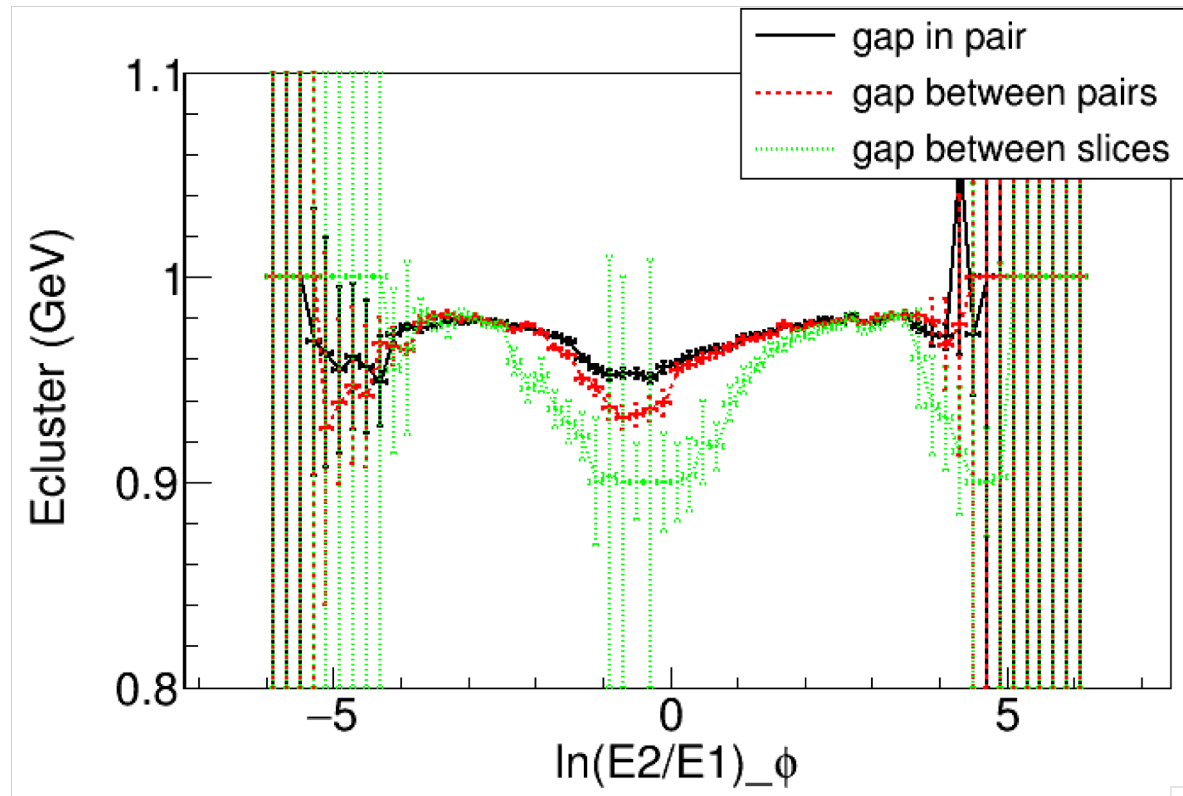
detID = iMod*1E8+iRow*1E6+iCopy*1E4+iCry



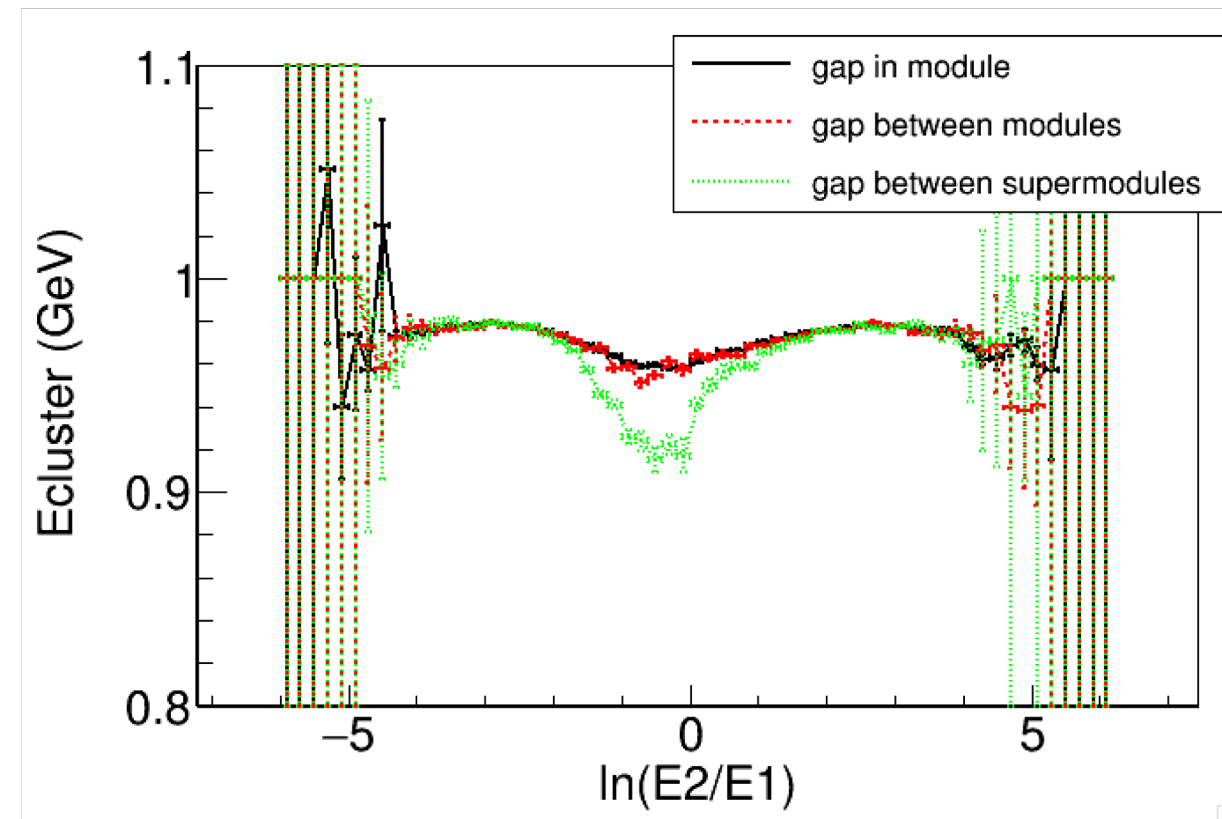
Energy calibration: correction for leakage in dead area

For different gaps

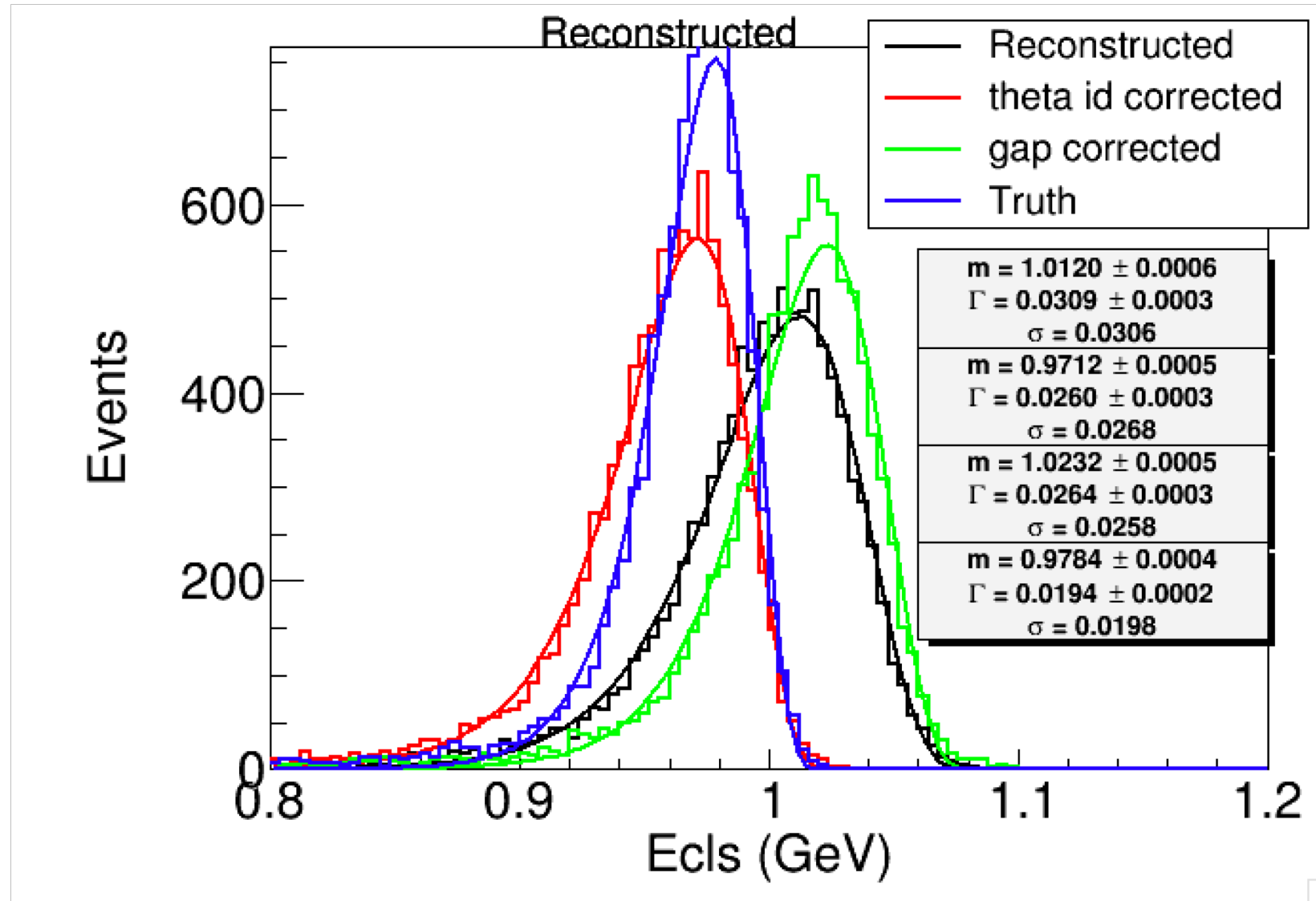
For $\theta=49.9$, $\ln(E2/E1)$ in phi direction



For $\phi=30.1$



Energy calibration: correction for leakage in dead area





Energy calibration: Status and Plan

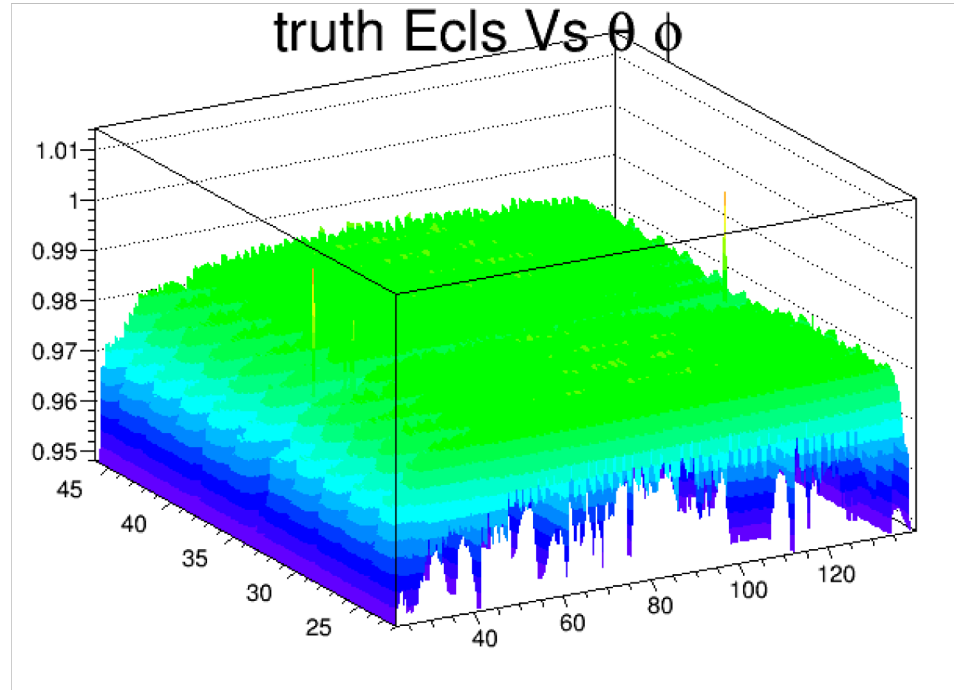
➤ Status: Calibration on each crystal

- ☐ Crystal type related correction
- ☐ Position and energy related correction
- ☐ energy relation for crystal type correction
- ☐ Cluster energy leakage correction, in dead area and at rear

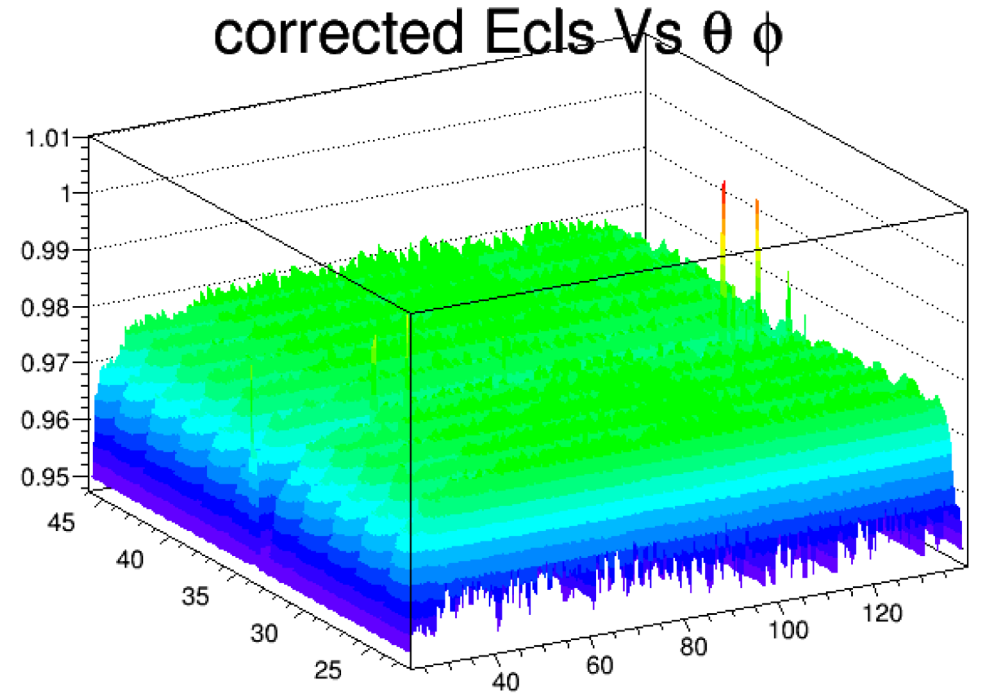
➤ Plan

- ☐ Nonuniformity correction
- ☐ MVA or ML for energy correction

truth Ecls Vs θ ϕ



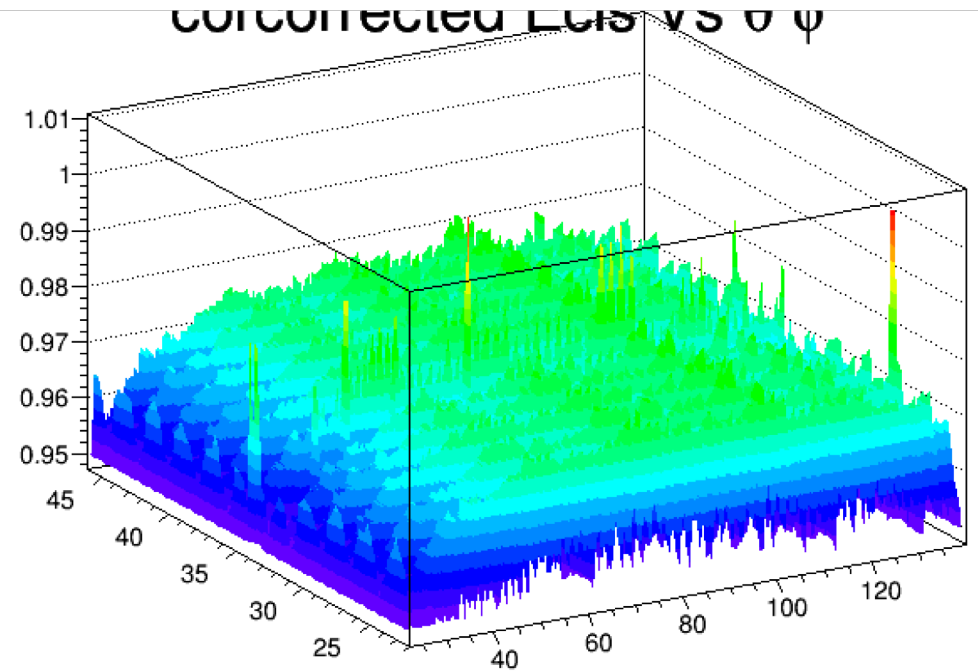
corrected Ecls Vs θ ϕ



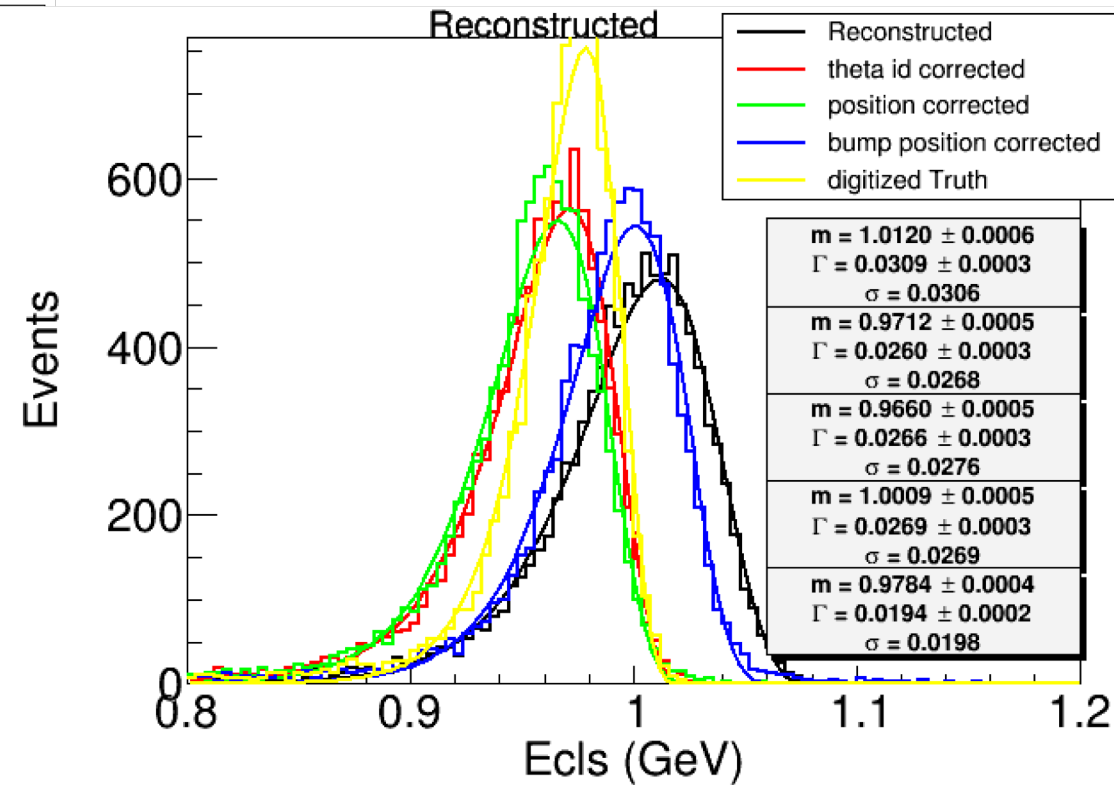
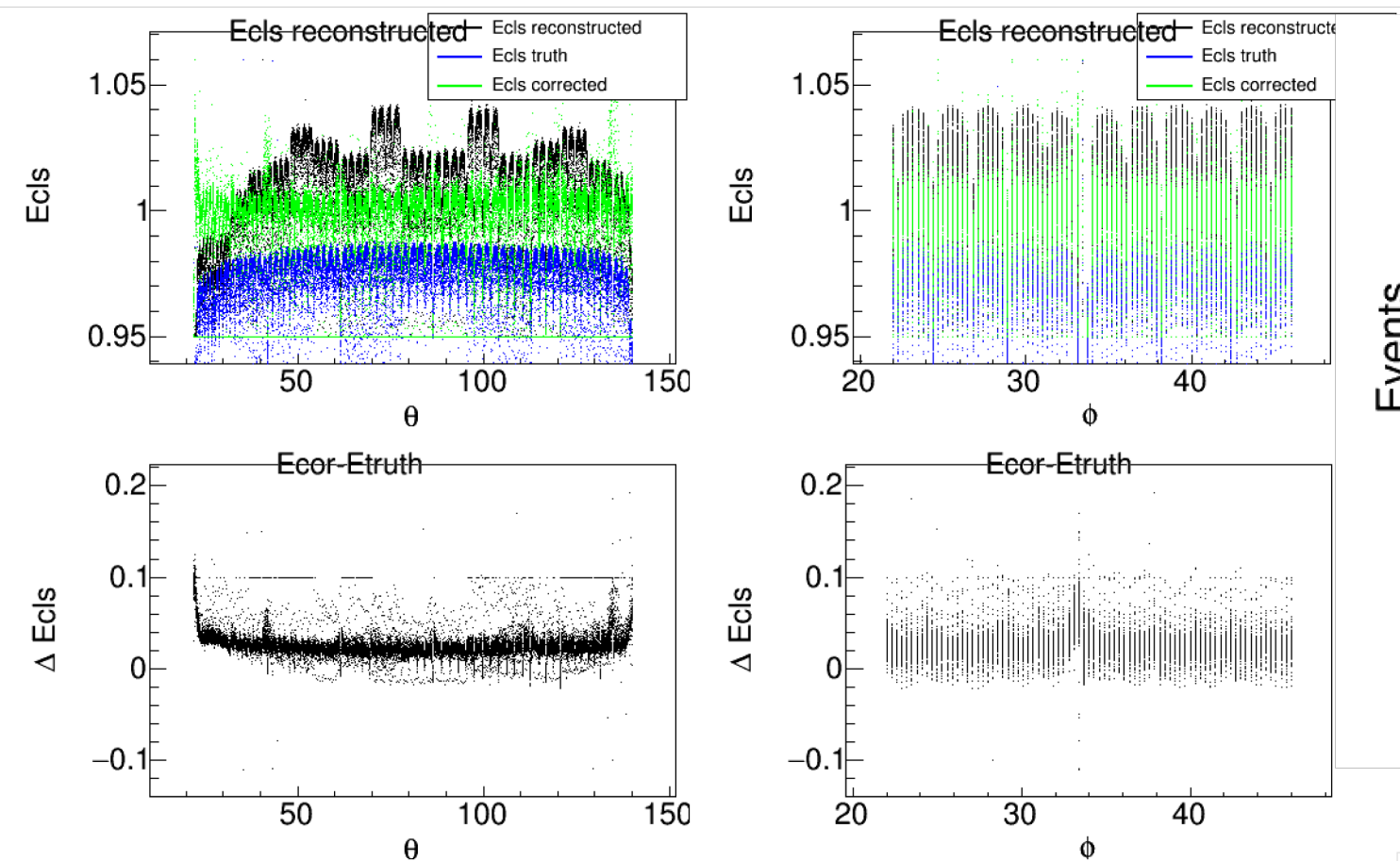
Problems:

For scan sample, position uncertainty
affect the result

corrected Ecls Vs θ ϕ



Energy calibration: correction base on bump position



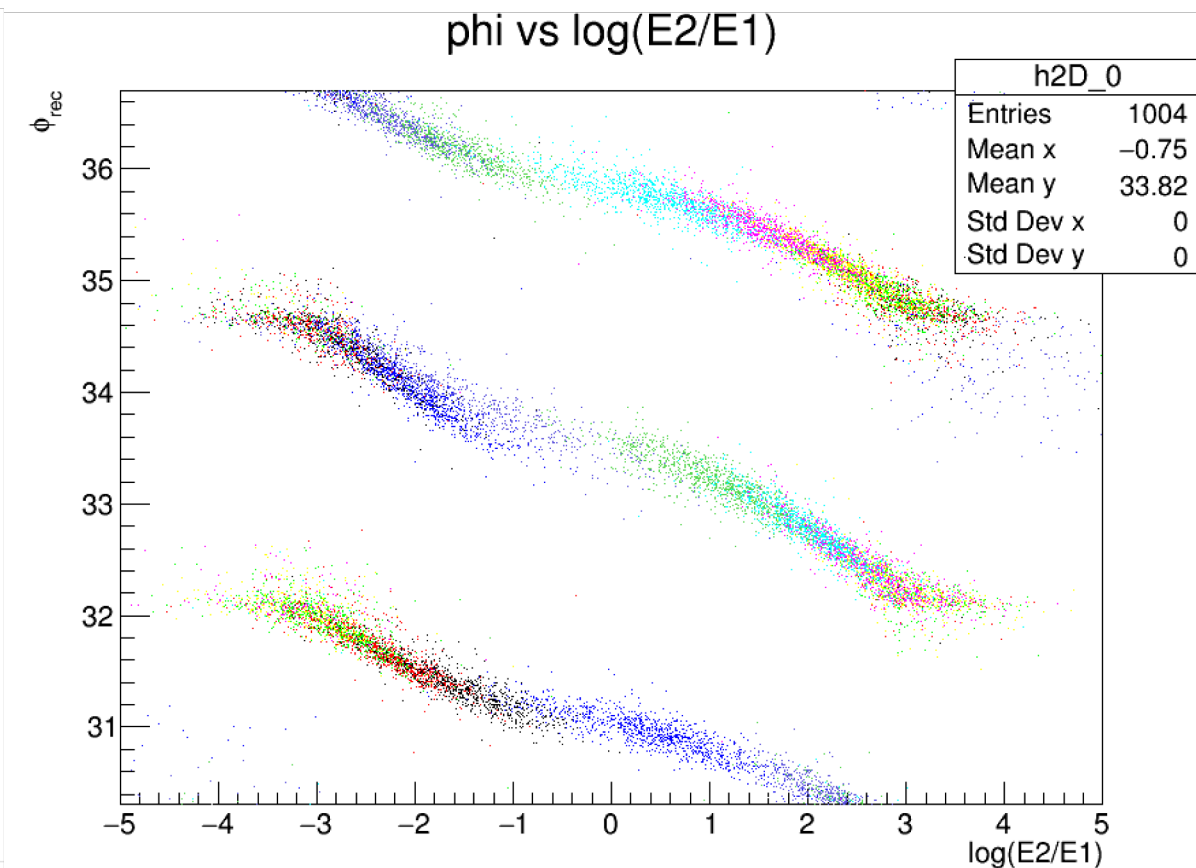
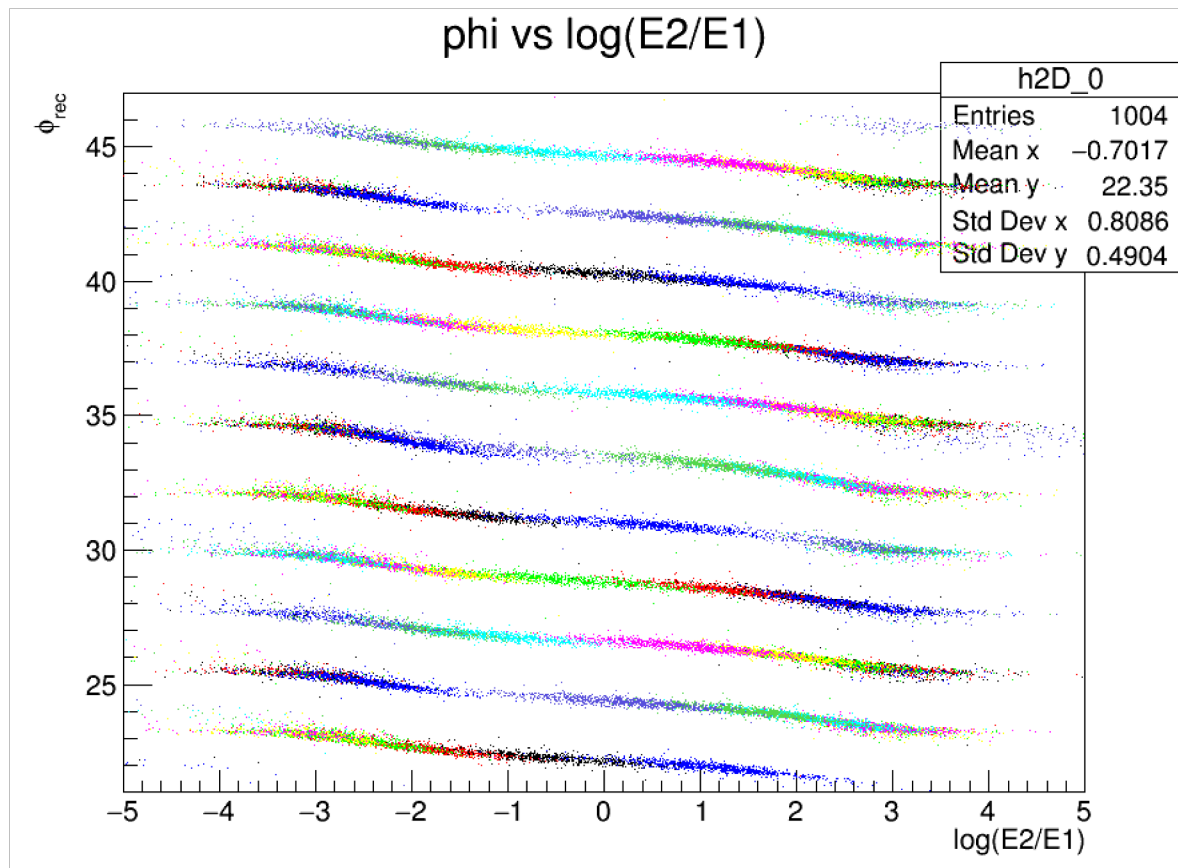
Position calibration

Position calibration

Based on i theta correction

For $\theta=49.9$

One color corresponding to one sample



Position calibration Based on i theta correction

For $\phi=30.1$

One color corresponding to one sample

